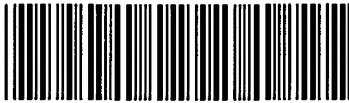


**Search Notes**

Application/Control No.

10/648,367

Examiner

Julie E. Stein, Esq.

Applicant(s)/Patent under  
Reexamination

IIDA, TAKAYUKI

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
348	211.2	3/21/2006	JES
348	211.14	3/21/2006	JES

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT,PGPUB-text search--see attached	3/21/2006	JES
EPO,JPO,DERWENT-text search-see attached	3/21/2006	JES